MOSFET – N-Channel, POWERTRENCH[®], SyncFET™

25 V, 40 A, 2 m Ω

General Description

The FDMC7570S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $R_{DS(on)}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Features

- Max $R_{DS(on)} = 2 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 27 \text{ A}$
- Max $R_{DS(on)} = 2.9 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 21.5 \text{ A}$
- Advanced Package and Combination for Low R_{DS(on)} and High Efficiency
- SyncFET Schottky Body Diode
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/GPU Low Side Switch
- Networking Point of Load Low Side Switch
- Telecom Secondary Side Rectification

MAXIMUM RATINGS (T_A = 25° C unless otherwise noted)

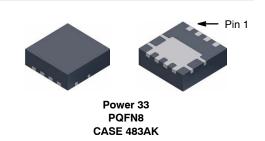
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Parameter	Symbol	Rating	Unit
Drain to Source Voltage	V _{DS}	25	V
Gate to Source Voltage (Note 4)	V _{GS}	±20	V
Drain Current - Continuous (Package limited) $T_C = 25^{\circ}C$ - Continuous (Silicon limited) $T_C = 25^{\circ}C$ - Continuous $T_A = 25^{\circ}C$ (Note 1a) - Pulsed	I _D	40 132 27 120	A
Single Pulse Avalanche Energy (Note 3)	E _{AS}	144	mJ
Power Dissipation $T_{C} = 25^{\circ}C$	PD	59	W
Power Dissipation $T_A = 25^{\circ}C$ (Note 1a)		2.3	
Operating and Storage Junction Temperature Range	T _J , T _{STG}	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

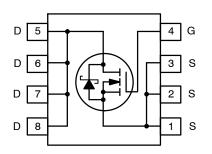


ON Semiconductor®

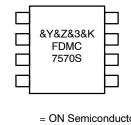
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MARKING DIAGRAM



= ON Semiconductor Logo = Assembly Plant Code

= As	ssembly	Plant	Coa
- 2		ta Co	do

- = 3-Digit Data Code = 2-Digit Lot Traceability Code
- FDMC7570S = Specific De

&Y

&Z &3

&K

= Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC7570S	PGFN8 (Pb-Free)	3,000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal Resistance, Junction to Case	Rejc	2.1	°C/W
Thermal Resistance, Junction to Ambient (Note 1a)	Reja	53	

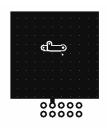
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTIC						
Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	BVDSS	25			V
Breakdown Voltage Temperature / Coefficient	I_D = 10 mA, referenced to 25°C	$\frac{\Delta \text{BV}_{\text{DSS}}/}{\Delta \text{T}_{\text{J}}}$		21		mV/°C
Zero Gate Voltage Drain Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	IDSS			500	μA
Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V	lgss			100	nA
ON CHARACTERISTICS					-	
Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	VGS(th)	1.2	1.7	3	V
Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to $25^{\circ}C$	$\frac{\Delta \text{VGS(th)}}{\Delta \text{T}_{\text{J}}}$		-4		mV/°C
Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 27 A	RDS(on)		1.6	2	mΩ
	V _{GS} = 4.5 V, I _D = 21.5 A			2.4	2.9	
	V_{GS} = 10 V, I _D = 27 A, T _J = 125°C			2.2	2.8	
Forward Transconductance	V _{DS} = 5 V, I _D = 27 A	gfs		154		S
DYNAMIC CHARACTERISTICS					-	
Input Capacitance	V_{DS} = 13 V, V_{GS} = 0 V, f = 1 MHz	Ciss		3315	4410	pF
Output Capacitance		Coss		1010	1345	pF
Reverse Transfer Capacitance		Crss		168	255	pF
Gate Resistance		R _g		1.2	2.1	Ω
SWITCHING CHARACTERISTICS					-	
Turn-On Delay Time	$V_{DD} = 13 \text{ V}, \text{ I}_{D} = 27 \text{ A}, \text{ V}_{GS} = 10 \text{ V},$	td(on)		14	26	ns
Rise Time	$R_{GEN} = 6 \Omega$	t _r		6.8	14	ns
Turn-Off Delay Time		td(off)		34	55	ns
Fall Time		t _f		4.5	10	ns
Total Gate Charge	V_{GS} = 0 V to 10 V, V_{DD} = 13 V	Qg		49	68	nC
Total Gate Charge	V_{GS} = 0 V to 4.5 V, V_{DD} = 13 V	Qg		22	31	nC
Gate to Source Gate Charge	I _D = 27 A	Qgs		10.8		nC
Gate to Drain "Miller" Charge	-	Qgd		5.5		nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 27 A (Note 2)	Vsd		0.78	1.2	V
	V _{GS} = 0 V, I _S = 2 A (Note 2)	1 1		0.43	0.8	1
Reverse Recovery Time	I _F = 27 A, di/dt = 300 A/μs	trr		30	48	ns
Reverse Recovery Charge	1	Qrr		29	46	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 53°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. E_{AS} of 144 mJ is based on starting T_J = 25°C, L = 1 mH, I_{AS} = 17 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 25 A. 4. As an N-ch device, the negative Vgs rating is for lower duty cycle pulse occurrence only. No continuous rating is implied.

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

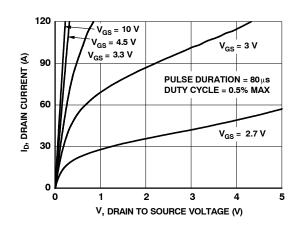


Figure 1. On–Region Characteristics

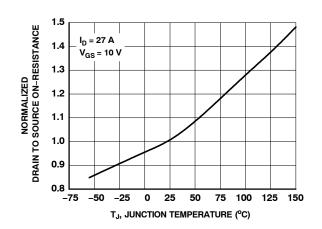


Figure 3. Normalized On-Resistance vs. Junction Temperature

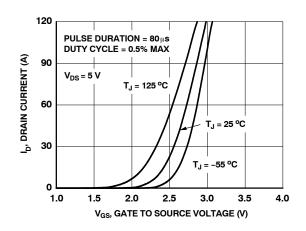


Figure 5. Transfer Characteristics

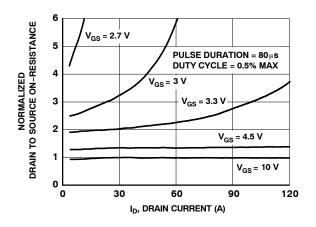


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

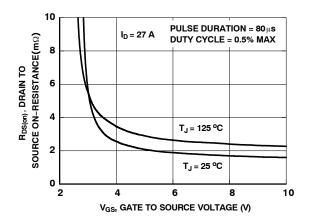


Figure 4. On–Resistance vs. Gate to Source Voltage

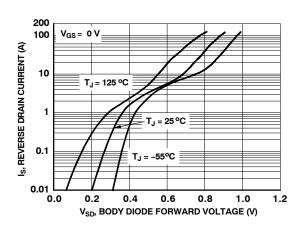


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS (continued)

(T_J = 25° C unless otherwise noted)

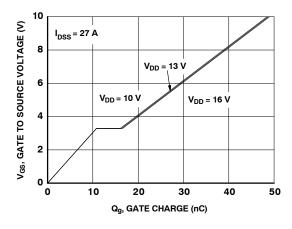


Figure 7. Gate Charge Characteristics

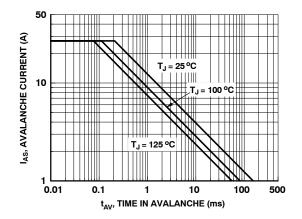


Figure 9. Unclamped Inductive Switching Capability

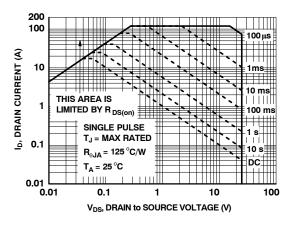


Figure 11. Forward Bias Safe Operating Area

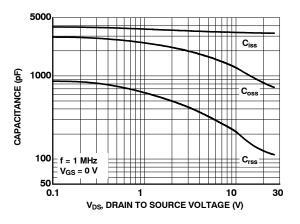


Figure 8. Capacitance vs Drain to Source Voltage

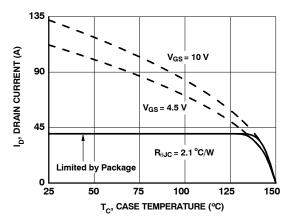
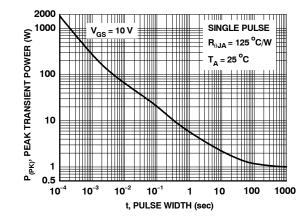


Figure 10. Maximum Continuous Drain Current vs Case Temperature





TYPICAL CHARACTERISTICS (continued)

(T_J = 25° C unless otherwise noted)

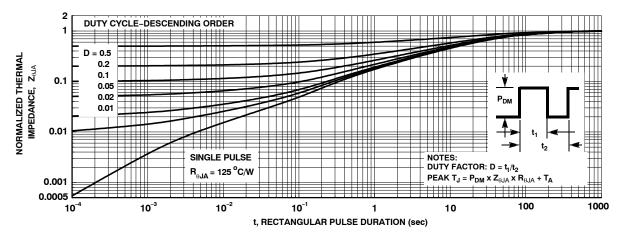


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

SyncFET SCHOTTKY BODY DIODE CHARACTERISTICS

ON Semiconductor's SyncFET process embeds a Schottky diode in parallel with POWERTRENCH MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMC7570S. Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

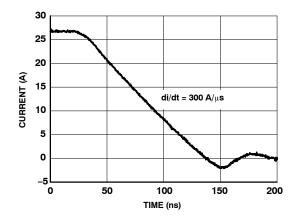


Figure 14. FDMC7570S SyncFET Body Diode Reverse Recovery Characteristic

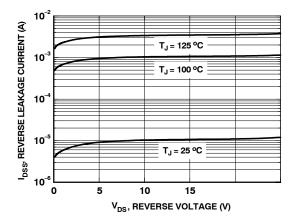


Figure 15. SyncFET Body Diode Reverse Leakage vs. Drain-Source Voltage

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DUDSem

MAX.

1.10

0.05

0.37

3.40

2.37

0.62

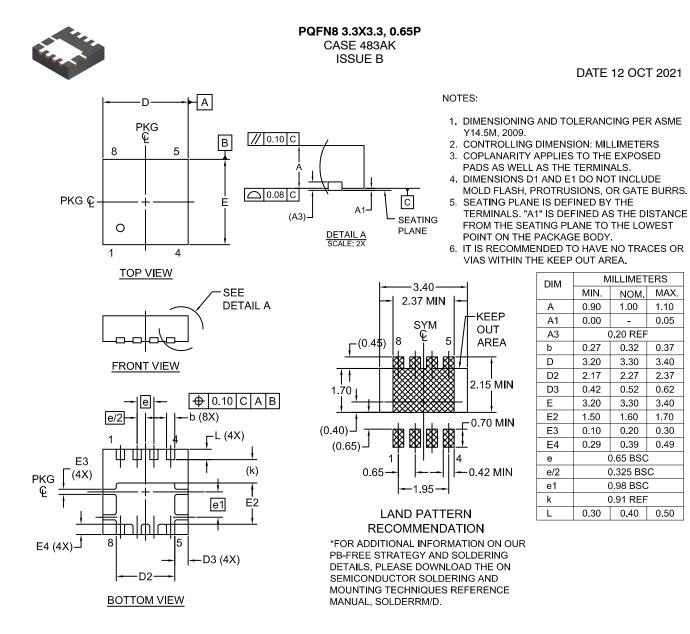
3.40

1.70

0.30

0.49

0.50



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